

US-31261-UL

## IEC SYSTEM FOR MUTUAL RECOGNITION OF TEST CERTIFICATES FOR ELECTRICAL EQUIPMENT (IECEE) CB SCHEME

## **CB TEST CERTIFICATE**

Product

Name and address of the applicant

Name and address of the manufacturer

Name and address of the factory

Note: When more than one factory, please report on page 2

Ratings and principal characteristics

Trademark (if any)

3 in 1 Card Reader

ID TECH 10721 WALKER ST CYPRESS CA 90630-4720 USA

ID TECH 10721 WALKER ST CYPRESS CA 90630-4720 USA

ID TECH TAIWAN CO LTD 16 LANE 22 GAOQING RD YANGMEI TAOYUAN HSIEN 326 TAIWAN Additional Information on page 2

Optional (Class III supplied by SELV) 7.5 - 45Vdc, 3W



Type of Customer's Testing Facility (CTF) Stage used

Additional information (if necessary may also be

A sample of the product was tested and found

As shown in the Test Report Ref. No. which forms

Model / Type Ref.

reported on page 2)

to be in conformity with

part of this Certificate

VP6300

Additionally evaluated to EN 60950-1: 2006 / A11: 2009 / A1: 2010 / A12: 2011 / A2:2013; National Differences specified in the ACB Test Report.

Additional Information on page 2

IEC 60950-1(ed.2), IEC 60950-1(ed.2);am1, IEC 60950-1(ed.2);am2 E235836-A10-CB-1 issued on 2018-02-14

## This CB Test Certificate is issued by the National Certification Body

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Signature:



UL (US), 333 Pfingsten Rd IL 60062, Northbrook, USA UL (Demko), Borupvang 5A DK-2750 Ballerup, DENMARK UL (JP), Marunouchi Trust Tower Main Building 6F, 1-8-3 Marunouchi, Chiyoda-ku, Tokyo 100-0005, JAPAN UL (CA), 7 Underwriters Road, Toronto, M1R 3B4 Ontario, CANADA For full legal entity names see www.ul.com/ncbnames

Date: 2018-02-16

Jolanta M. Wroblewska